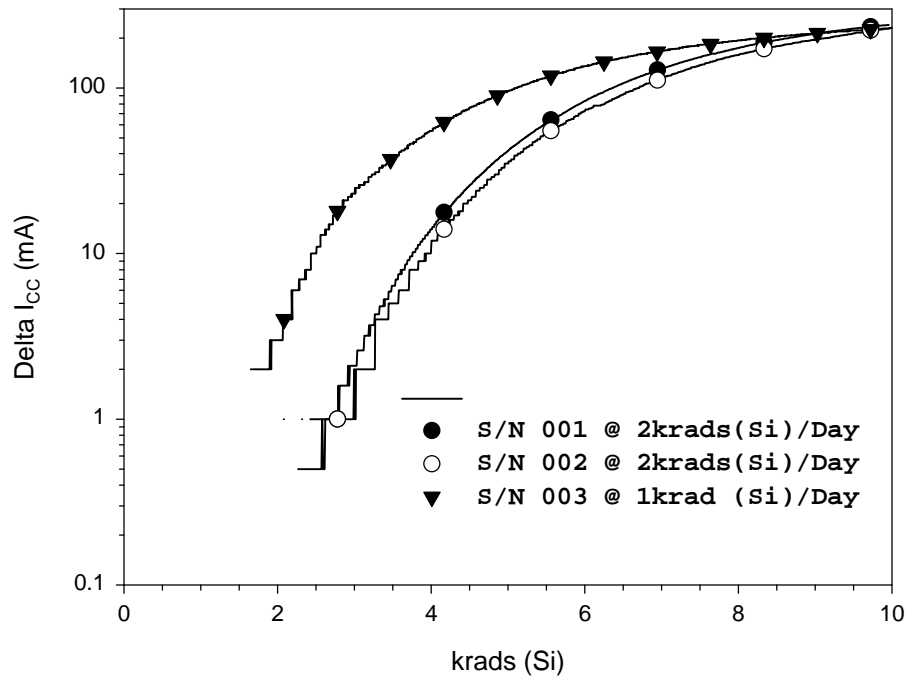
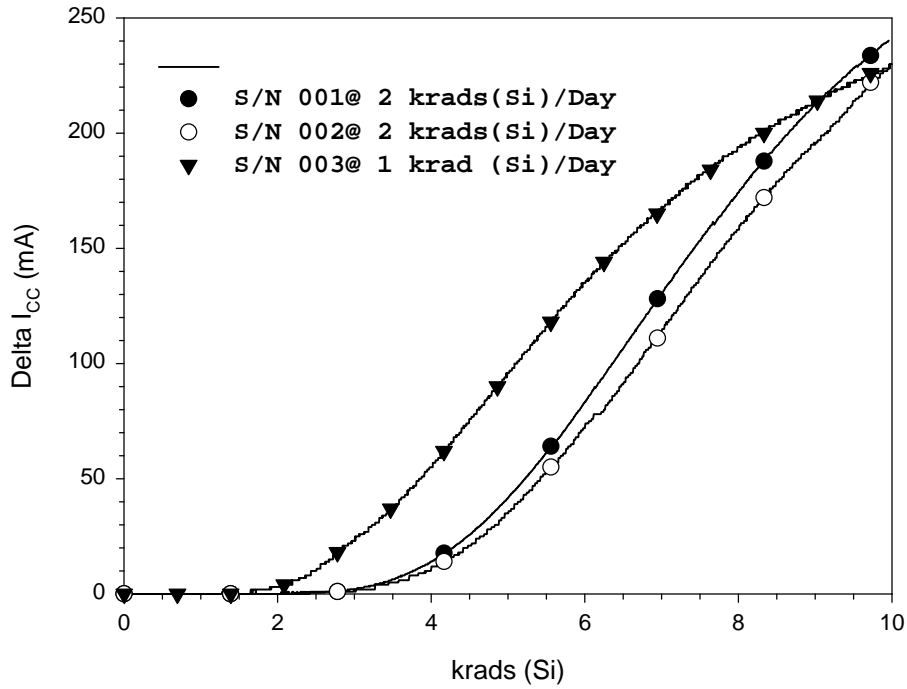


MAP A1280A TID TEST
 NASA/GSFC
 Dec. 29, 1997
 2 krad(Si)/Day for S/N 001, 002
 1 krad(Si)/Day for S/N 003
 D/C 9729
 L/C U1H428



Note: After some unbiased annealing (facility accessibility) S/N 001 was functional and had an I_{cc} of ~ 25 mA. Under a powered, room temperature anneal, S/N 001 was tested continuously for several days and I_{cc} dropped to ~ 18 mA.